


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/633,642	FURUKAWA ET AL.	
	Examiner	Art Unit	
	Rick K. Chang	3729	

SEARCHED			
Class	Subclass	Date	Examiner
search	updated	3/29/2006	RC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east search	3/29/2006	RC